

Search Notes

Application/Control No.

10/757,794

Examiner

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Applicant(s)/Patent under
Reexamination

HARPER ET AL.

Art Unit

1722

SEARCHED

Class	Subclass	Date	Examiner
425	384, 407	3/17/2006	TN
425	387.1	3/17/2006	TN
425	405.1	3/17/2006	TN
425	437, 444	3/17/2006	TN
425	810	3/17/2006	TN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search	3/17/2006	TN